

Application/Control No.	Applicant(s)/Patent under Reexamination
09/843,036	TRAPANI ET AL.
Examiner	Art Unit
Quoc A. Tran	2176

	SEAR	CHED	-
Class	Subclass	Date	Examiner
715	530	B 14/2006	8
			_

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u></u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		7)
	DATE	EXMR
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB)ee Search Histoty Printout	29 4/2006	Ø
ACM Databaseee Search History Printout	9 /4/2006	8

Search Notes				

Application No.	Applicant(s)	
09/843,036	TRAPANI ET AL.	
Examiner	Art Unit	
Ounc A Tran	2176	

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	513	9-14-04	W.
	526 514		
345	866		
	760		
709	223		
	246		
717	159		
-	114		<u> </u>
715	501.1	5/24/05	60
		, ,,	

Subclass	Date	Examiner
	1	
		· · · · · · · · · · · · · · · · · · ·
•		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
INVENTUR SCAROHI CHECK FOR	3/14/06	r et
Double PATENT	1	
US PAT		
VS PG-PUB	 	 - - - - - - - - -
500 Jp0		
DERWENCT		
PLUS : ETC	 	
PLUS : EIC		
INTER NET PERSONAL DILESTS		
up doteolaboul	5/24/05	- 6
	, ,	
		
	 	-
	<u> </u>	
	1	1